

**Search Notes**

Application/Control No.

10/642,945

Examiner

Kien T. Nguyen

Applicant(s)/Patent under  
Reexamination

KRYSIK ET AL.

Art Unit

3711

**SEARCHED**

Class	Subclass	Date	Examiner
473	597-609	6/26/2006	KN
473	143-145	6/26/2006	KN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR